April 2000

SEMICONDUCTOR TM

NDS9410A

-AIRCHILD

Single N-Channel Enhancement Mode Field Effect Transistor

General Description

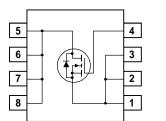
This N-Channel Logic Level MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

These devices are particularly suited for low voltage applications such as notebook computer power management and other battery powered circuits where fast switching, low in-line power loss and resistance to transients are needed.

Features

- + 7.3 A, 30 V. $R_{DS(ON)} = 28 \ m\Omega \ @ V_{GS} = 10 \ V$ $R_{DS(ON)} = 42 \ m\Omega \ @ V_{GS} = 4.5 \ V$
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- High power and current handling capability in a widely used surface mount package.





Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		30	V
V _{GSS}	Gate-Source Voltage		±20	V
I _D	Drain Current – Continuous	(Note 1a)	7.3	A
	- Pulsed		20	
PD	Power Dissipation for Single Operation	(Note 1a)	2.5	W
		(Note 1b)	1.2	
		(Note 1c)	1.0	
T _J , T _{STG}	Operating and Storage Junction Temperat	ture Range	-55 to +150	°C
Therma	I Characteristics	·		,
			50	

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
R _{θJC}	Thermal Resistance, Junction-to-Case	(Note 1)	25	°C/W
				· · · · ·

Package Marking and Ordering Information

NDS9410A NDS9410A 13" 12mm 25	uantity		Tape width	Reel Size	Device	Device Marking
	i00 units	2	12mm	13"	NDS9410A	NDS9410A

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 $T_{A} = 25^{\circ}C$ unless otherwise noted Min Max Units **Test Conditions** Тур V $V_{GS} = 0 V, I_D = 250 \mu A$ 30 $I_D = 250 \ \mu\text{A}$, Referenced to 25°C 28 mV/°C $V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$ 2 μA $V_{GS} = 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$ 100 nA $V_{GS} = -20 V V_{DS} = 0 V$ -100 nA $V_{DS} = V_{GS}, I_D = 250 \ \mu A$ V 1 1.6 З $I_D = 250 \ \mu\text{A}$, Referenced to 25°C -4.3 mV/°C $V_{GS} = 10 \text{ V}, \text{ I}_{D} = 7.3 \text{ A}$ 19 28 mΩ $V_{GS} = 10 \ V, \ \ I_D = 7.3 \ A, \ T_J {=} 125^{\circ}C$ 30 45 25 42 $V_{GS} = 4.5 \text{ V}, \ I_D = 6.3 \text{ A}$ $V_{GS} = 4.5 \ V, \ I_D = 6.3 \ A, \ T_J {=} 125^{\circ}C$ 42 75 $V_{GS} = 10 V, V_{DS} = 5 V$ 20 А s $I_{D} = 7.3 \text{ A}$ 22

Dynamic Characteristics

Electrical Characteristics

Coefficient

Parameter

Drain-Source Breakdown Voltage

Breakdown Voltage Temperature

Zero Gate Voltage Drain Current

Gate-Body Leakage, Forward

Gate-Body Leakage, Reverse

Gate Threshold Voltage

Gate Threshold Voltage

Temperature Coefficient

On–State Drain Current

Forward Transconductance

Static Drain-Source

On-Resistance

(Note 2)

Symbol

BV_{DSS}

 ΔBV_{DSS}

 ΔT_{J}

IDSS

IGSSF

IGSSR

V_{GS(th)}

 $\Delta V_{GS(th)}$

 ΔT_{J} R_{DS(on)}

I_{D(on)}

gfs

Off Characteristics

On Characteristics

D ynan						
C _{iss}	Input Capacitance	$V_{DS} = 15 V, V_{GS} = 0 V,$		830		pF
C _{oss}	Output Capacitance	f = 1.0 MHz		185		pF
Crss	Reverse Transfer Capacitance			80		pF

 $V_{DS} = 15 V$,

Switching Characteristics (Note 2)

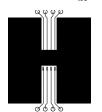
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 25 \text{ V}, I_D = 1 \text{ A},$	6	12	ns
t _r	Turn–On Rise Time	$V_{GS} = 10$ V, $R_{GEN} = 6 \Omega$	10	20	ns
$t_{d(off)}$	Turn-Off Delay Time		18	32	ns
t _f	Turn–Off Fall Time		5	10	ns
Qg	Total Gate Charge	$V_{DS} = 15 V, I_D = 2 A,$	14	22	nC
Q_{gs}	Gate-Source Charge	$V_{GS} = 10 V$	2.7		nC
Q_{gd}	Gate-Drain Charge		3.0		nC

Drain–Source Diode Characteristics and Maximum Ratings

ls	Maximum Continuous Drain-Source	Diode Forward Current			2.2	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS}=0~V,~~I_S=2.2~A$	(Note 2)	0.78	1.1	V

Notes:

1. R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta,C}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%





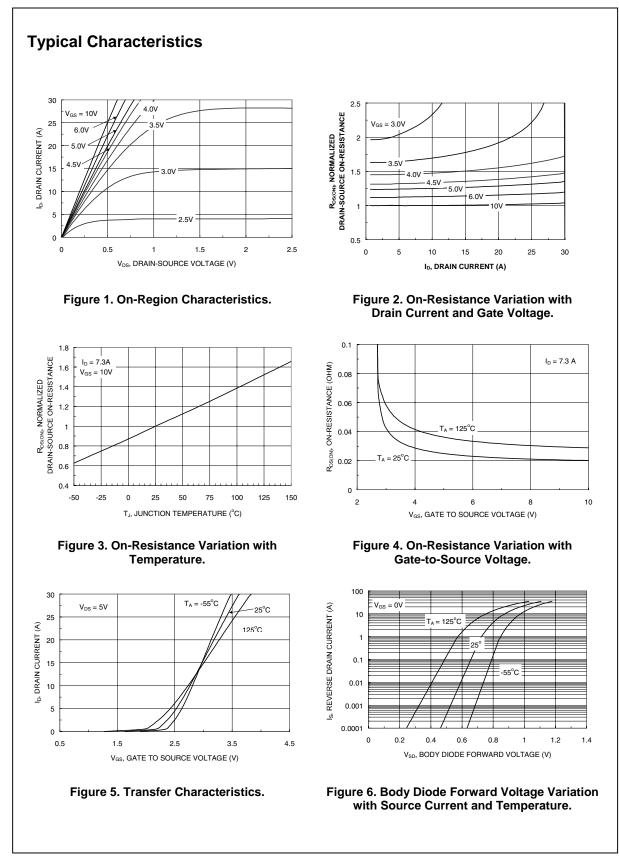
b) 105°/W when mounted on a .04 in² pad of 2 oz copper

c) 125°/W when mounted on a

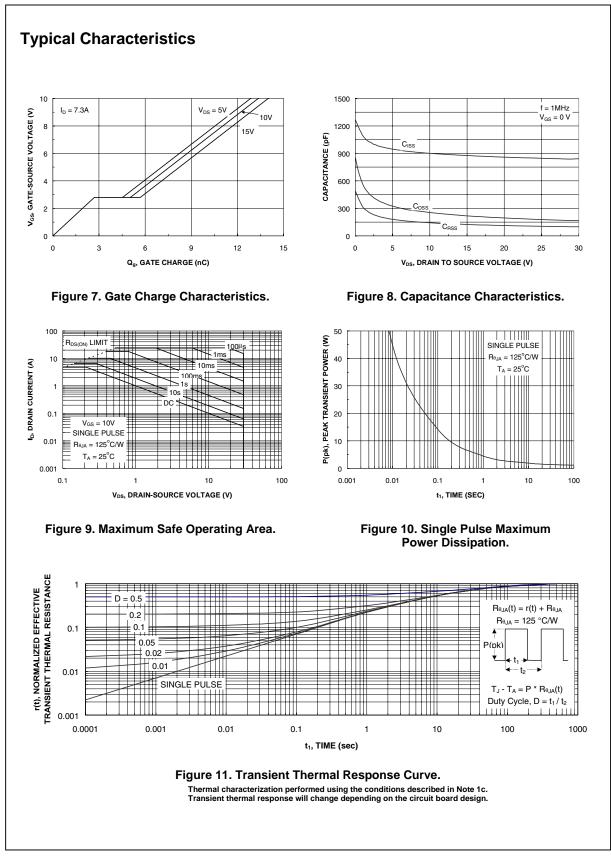
minimum pad.



NDS9410A



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NDS9410A Rev B(W)

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